Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/566,583	KAMEDA, FUTOSHI	
Examiner	Art Unit	
Lindsay M. Low	3721	

SEARCHED			
Class	Subclass	Date	Examiner
227	107, 119, 120, 135, 139	7/23/2007	LL
,			
	-		
		weller we	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

(INCLUDING SEA	H NOTES ARCH STRATEG	Υ)
	DATE	EXMR
· · · · · · · · · · · · · · · · · · ·		
		